# MOSFET - Power, Single N-Channel

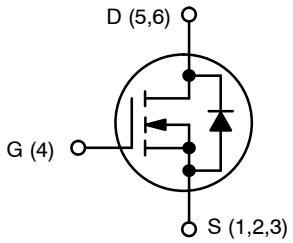
## 40 V, 2.95 mΩ, 161 A

## NVMFS5831NL

| $V_{(BR)DSS}$ | $R_{DS(ON)}$ MAX | $I_D$ MAX |
|---|---|---|
| 40 V | 2.95 mΩ @ 10 V | 161 A |
| | 4.8 mΩ @ 4.5 V | |

### Features

- Small Footprint (5x6 mm) for Compact Design
- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low $Q_G$ and Capacitance to Minimize Driver Losses
- NVMFS5831NLWF – Wettable Flanks Product
- AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb–Free and are RoHS Compliant




N–CHANNEL MOSFET

### MAXIMUM RATINGS ($T_J$ = 25°C unless otherwise noted)

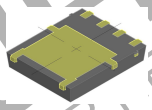
| Parameter | | | Symbol | Value | Unit |
|---|---|---|---|---|---|
| Drain–to–Source Voltage | | | $V_{DSS}$ | 40 | V |
| Gate–to–Source Voltage | | | $V_{GS}$ | ± 20 | V |
| Continuous Drain Current $R_{\Psi J-mb}$ (Notes 1, 2, 3, 4) | Steady State | $T_{mb}$ = 25°C | $I_D$ | 161 | A |
| | | $T_{mb}$ = 100°C | | 114 | |
| Power Dissipation $R_{\Psi J-mb}$ (Notes 1, 2, 3) | | $T_{mb}$ = 25°C | $P_D$ | 143 | W |
| | | $T_{mb}$ = 100°C | | 72 | |
| Continuous Drain Current $R_{\theta JA}$ (Notes 1, 3, 4) | Steady State | $T_A$ = 25°C | $I_D$ | 26 | A |
| | | $T_A$ = 100°C | | 19 | |
| Power Dissipation $R_{\theta JA}$ (Notes 1, 3) | | $T_A$ = 25°C | $P_D$ | 3.8 | W |
| | | $T_A$ = 100°C | | 1.9 | |
| Pulsed Drain Current | $T_A$ = 25°C, $t_p$ = 10 μs | | $I_{DM}$ | 900 | A |
| Operating Junction and Storage Temperature Range | | | $T_J$, $T_{stg}$ | −55 to +175 | °C |
| Source Current (Body Diode) | | | $I_S$ | 119 | A |
| Single Pulse Drain–to–Source Avalanche Energy ($I_{L(pk)}$ = 23 A) | | | $E_{AS}$ | 683 | mJ |
| Lead Temperature for Soldering Purposes (1/8″ from case for 10 s) | | | $T_L$ | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

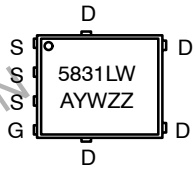
| Parameter | Symbol | Value | Unit |
|---|---|---|---|
| Junction–to–Mounting Board (top) – Steady State (Notes 2, 3) | $R_{\Psi J-mb}$ | 1.05 | °C/W |
| Junction–to–Ambient – Steady State (Note 3) | $R_{\theta JA}$ | 39.4 | |

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
3. Surface–mounted on FR4 board using a 650 $mm^2$, 2 oz. Cu pad.
4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



**DFNW5**
**(SO8FL)**
**CASE 507BA**

### MARKING DIAGRAM




| | |
|---|---|
| 5831LW | = Specific Device Code |
| A | = Assembly Location |
| Y | = Year |
| W | = Work Week |
| ZZ | = Lot Traceability |

### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

**ELECTRICAL CHARACTERISTICS** ($T_J$ = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|---|
| **OFF CHARACTERISTICS** | | | | | | | |
| Drain−to−Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS}$ = 0 V, $I_D$ = 250 μA | | 40 | | | V |
| Drain−to−Source Breakdown Voltage Temperature Coefficient | $V_{(BR)DSS}/T_J$ | | | | 38.9 | | mV/°C |
| Zero Gate Voltage Drain Current | $I_{DSS}$ | $V_{GS}$ = 0 V, $V_{DS}$ = 40 V | $T_J$ = 25 °C | | | 1 | μA |
| | | | $T_J$ = 125°C | | | 100 | |
| Gate−to−Source Leakage Current | $I_{GSS}$ | $V_{DS}$ = 0 V, $V_{GS}$ = ±20 V | | | | ±100 | nA |
| **ON CHARACTERISTICS** (Note 5) | | | | | | | |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS}$ = $V_{DS}$, $I_D$ = 250 μA | | 1.4 | | 2.4 | V |
| Negative Threshold Temperature Coefficient | $V_{GS(TH)}/T_J$ | | | | 6.17 | | mV/°C |
| Drain−to−Source On Resistance | $R_{DS(on)}$ | $V_{GS}$ = 10 V | $I_D$ = 20 A | | 2.38 | 2.95 | mΩ |
| | | $V_{GS}$ = 4.5 V | $I_D$ = 20 A | | 3.66 | 4.8 | |
| Forward Transconductance | $g_{FS}$ | $V_{DS}$ = 15 V, $I_D$ = 20 A | | | 25.3 | | S |
| **CHARGES, CAPACITANCES & GATE RESISTANCE** | | | | | | | |
| Input Capacitance | $C_{ISS}$ | $V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 25 V | | | 4946 | | pF |
| Output Capacitance | $C_{OSS}$ | | | | 574 | | |
| Reverse Transfer Capacitance | $C_{RSS}$ | | | | 389 | | |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS}$ = 4.5 V, $V_{DS}$ = 32 V; $I_D$ = 20 A | | | 46.5 | | nC |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS}$ = 10 V, $V_{DS}$ = 32 V; $I_D$ = 20 A | | | 90 | | |
| Threshold Gate Charge | $Q_{G(TH)}$ | $V_{GS}$ = 4.5 V, $V_{DS}$ = 32 V; $I_D$ = 20 A | | | 9.1 | | |
| Gate−to−Source Charge | $Q_{GS}$ | | | | 14.2 | | |
| Gate−to−Drain Charge | $Q_{GD}$ | | | | 22 | | |
| Plateau Voltage | $V_{GP}$ | | | | 3.2 | | V |
| **SWITCHING CHARACTERISTICS** (Note 6) | | | | | | | |
| Turn−On Delay Time | $t_{d(ON)}$ | $V_{GS}$ = 4.5 V, $V_{DS}$ = 32 V, $I_D$ = 10 A, $R_G$ = 1.0 Ω | | | 22.5 | | ns |
| Rise Time | $t_r$ | | | | 24.7 | | |
| Turn−Off Delay Time | $t_{d(OFF)}$ | | | | 34.6 | | |
| Fall Time | $t_f$ | | | | 12.9 | | |
| **DRAIN−SOURCE DIODE CHARACTERISTICS** | | | | | | | |
| Forward Diode Voltage | $V_{SD}$ | $V_{GS}$ = 0 V, $I_S$ = 10 A | $T_J$ = 25°C | | 0.75 | 1.2 | V |
| | | | $T_J$ = 125°C | | 0.6 | | |
| Reverse Recovery Time | $t_{RR}$ | $V_{GS}$ = 0 V, dIS/dt = 100 A/μs, $I_S$ = 20 A | | | 35.6 | | ns |
| Charge Time | $t_a$ | | | | 19.2 | | |
| Discharge Time | $t_b$ | | | | 16.4 | | |
| Reverse Recovery Charge | $Q_{RR}$ | | | | 31.9 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

## TYPICAL CHARACTERISTICS

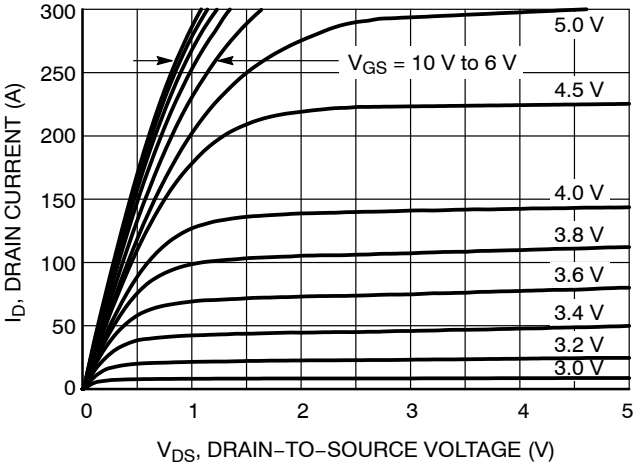



**Figure 1. On−Region Characteristics**

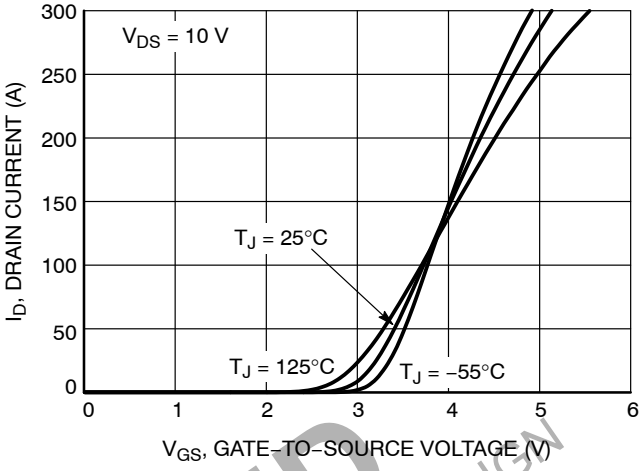



**Figure 2. Transfer Characteristics**

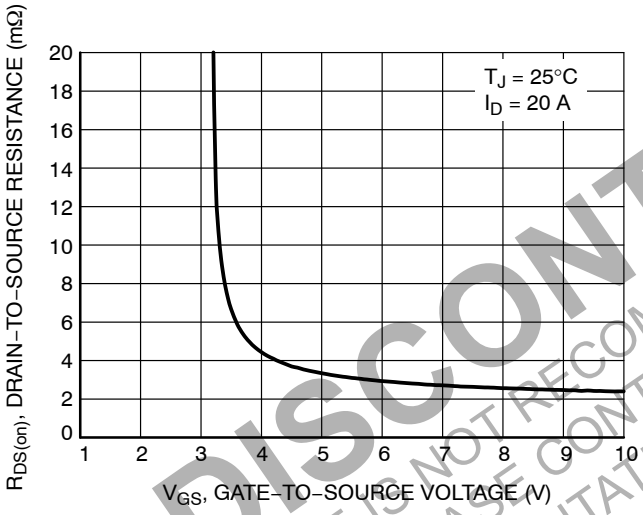



**Figure 3. On−Resistance vs. Gate−to−Source Voltage**

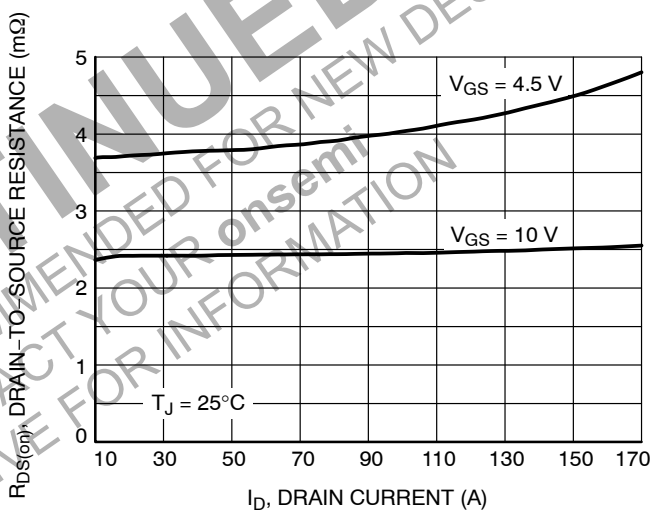



**Figure 4. On−Resistance vs. Drain Current and Gate Voltage**

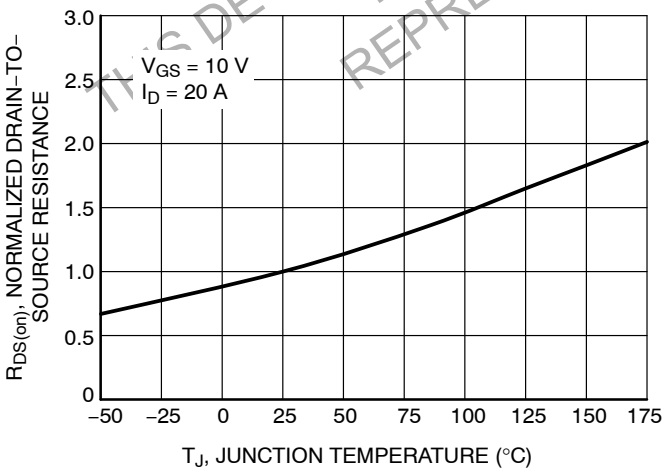



**Figure 5. On−Resistance Variation with Temperature**

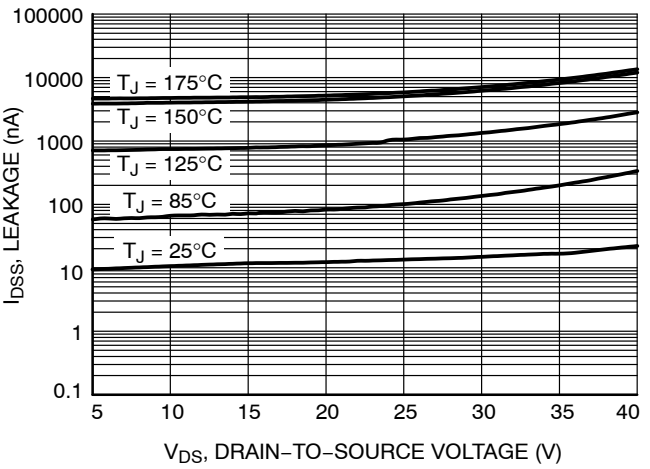



**Figure 6. Drain−to−Source Leakage Current vs. Voltage**

## TYPICAL CHARACTERISTICS

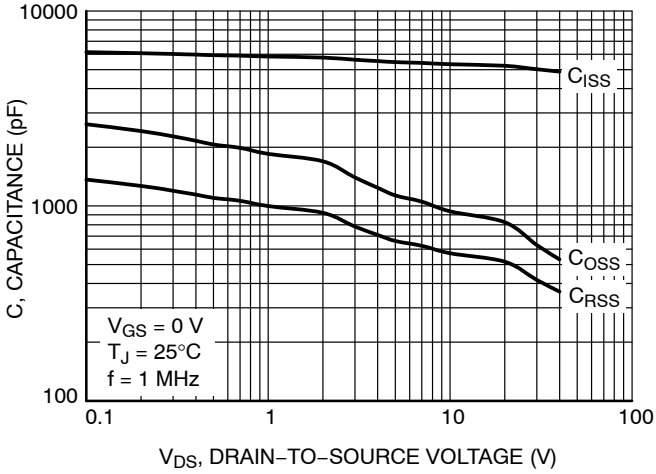



**Figure 7. Capacitance Variation**

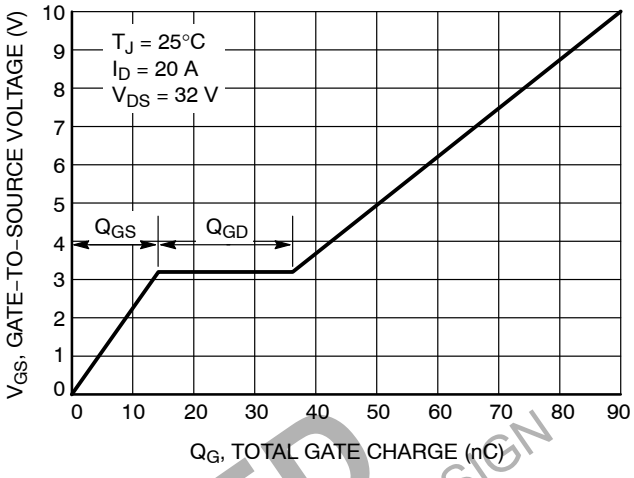



**Figure 8. Gate−to−Source Voltage vs. Total Charge**

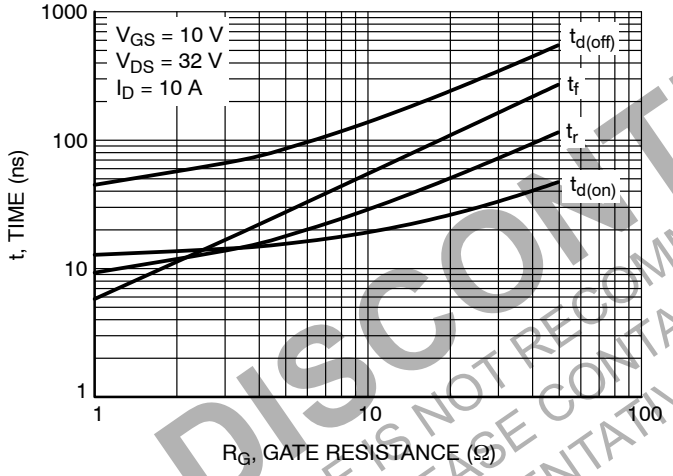



**Figure 9. Resistive Switching Time Variation vs. Gate Resistance**

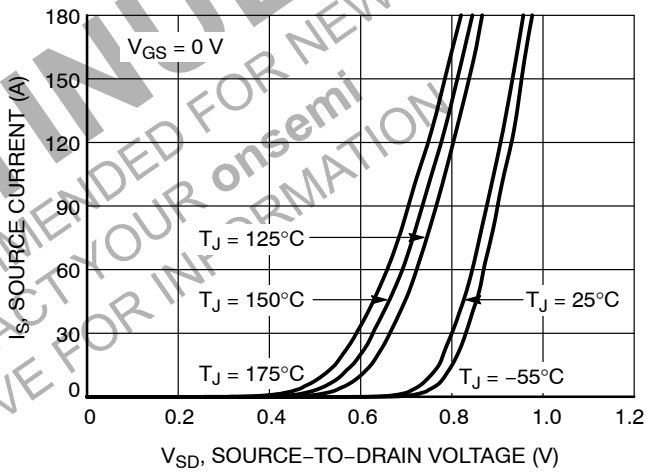



**Figure 10. Diode Forward Voltage vs. Current**

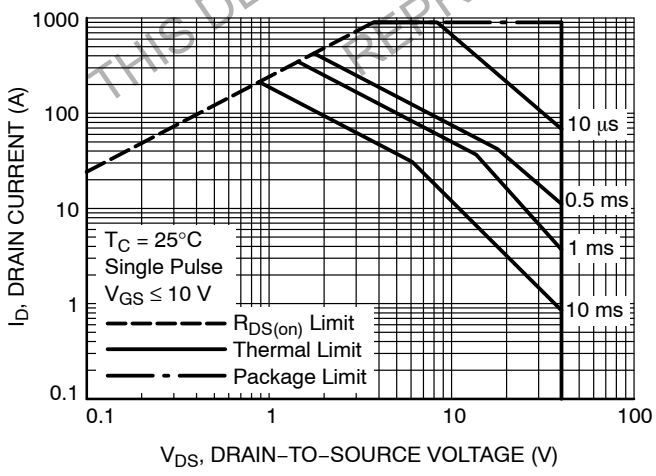



**Figure 11. Maximum Rated Forward Biased Safe Operating Area**

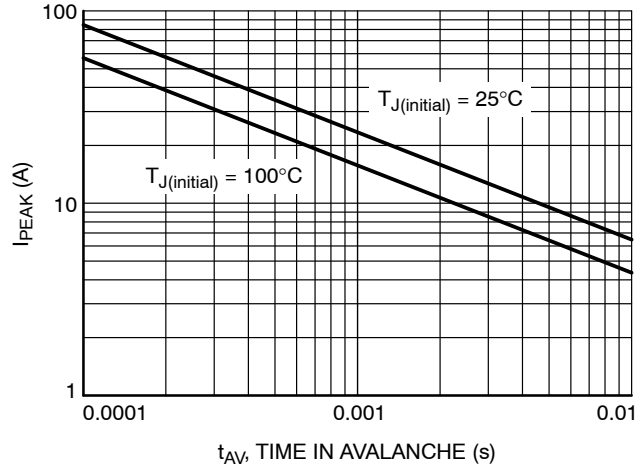



**Figure 12. Maximum Drain Current vs. Time in Avalanche**

## TYPICAL CHARACTERISTICS

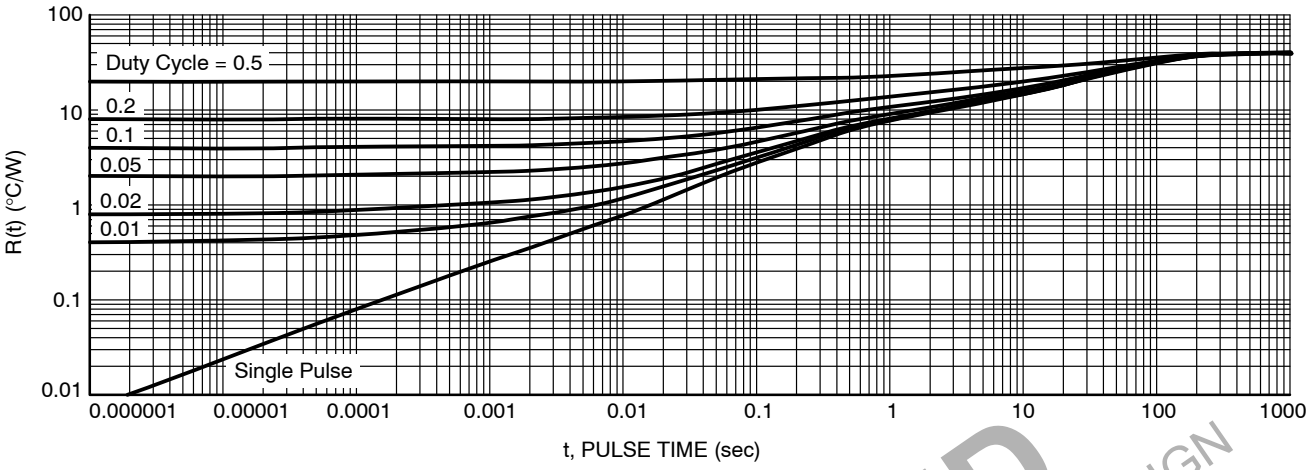



**Figure 13. Transient Thermal Impedance**



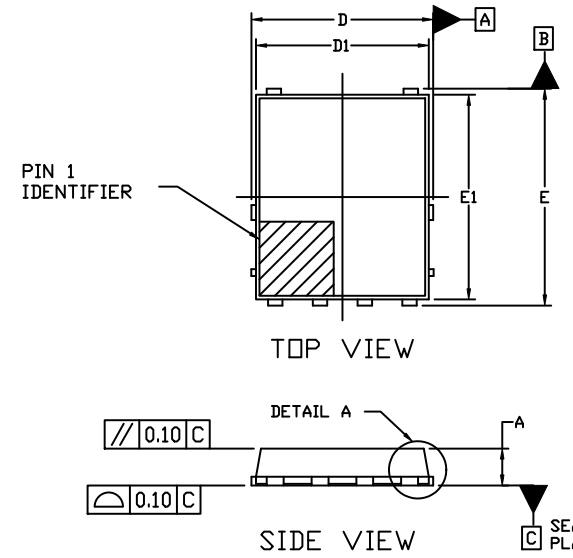
### DEVICE ORDERING INFORMATION

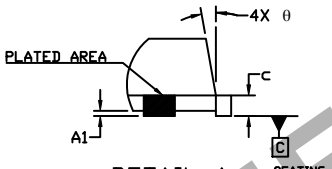
| Device | Marking | Package | Shipping† |
|---|---|---|---|
| NVMFS5831NLWFT1G | 5831LW | DFNW5<br>(Pb−Free) | 1500 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

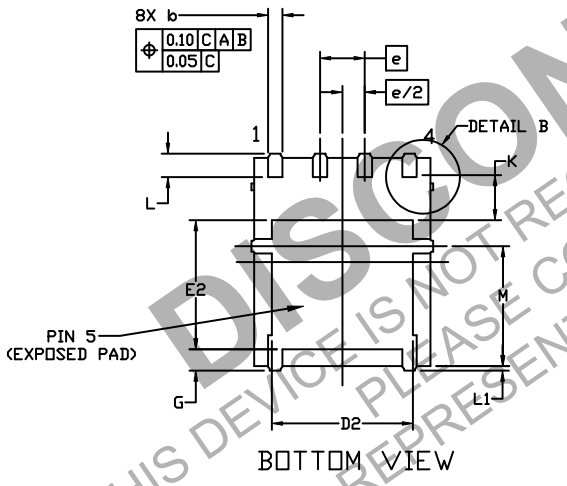
**DFNW5 5x6 (FULL−CUT SO8FL WF)**
CASE 507BA
ISSUE A

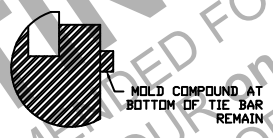


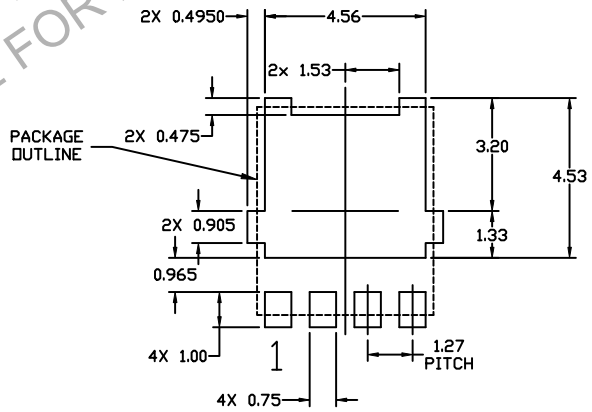




NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
4. THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.

| | MILLIMETERS | | |
|---|---|---|---|
| DIM | MIN. | NOM. | MAX. |
| A | 0.90 | 1.00 | 1.10 |
| A1 | 0.00 | --- | 0.05 |
| b | 0.33 | 0.41 | 0.51 |
| c | 0.23 | 0.28 | 0.33 |
| D | 5.00 | 5.15 | 5.30 |
| D1 | 4.70 | 4.90 | 5.10 |
| D2 | 3.80 | 4.00 | 4.20 |
| E | 6.00 | 6.15 | 6.30 |
| E1 | 5.70 | 5.90 | 6.10 |
| E2 | 3.45 | 3.65 | 3.85 |
| e | 1.27 BSC | | |
| G | 0.51 | 0.575 | 0.71 |
| K | 1.20 | 1.35 | 1.50 |
| L | 0.51 | 0.575 | 0.71 |
| L1 | 0.150 REF | | |
| M | 3.00 | 3.40 | 3.80 |
| θ | 0° | --- | 12° |




* For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## PUBLICATION ORDERING INFORMATION

**LITERATURE FULFILLMENT**:
**Email Requests to:** orderlit@onsemi.com

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**Europe, Middle East and Africa Technical Support:**
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For additional information, please contact your local Sales Representative

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